|                                   | Complete If Known      |                     |  |
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| Substitute for form 1449APTO      | Application Number     | 10/737,416          |  |
| INFORMATION DISCLOSURE            | Filing Date            | December 15, 2003   |  |
| STATEMENT BY APPLICANT            | First Named Inventor   | Oner, Hakan         |  |
| AIVIEWELL DILL LEGIT.             | Art Unit               | 2819                |  |
|                                   | Examiner Name          | CHO, JAMES HYONCHOL |  |
| (Use as many sheets as necessary) | Attorney Docket Number | 021803-000400US     |  |
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